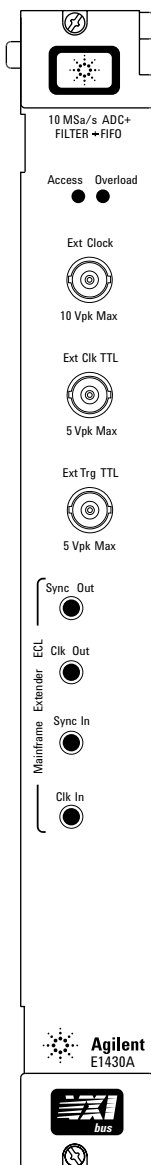


Agilent E1430A

10 MSample/sec ADC, with Filtering and Memory

Data Sheet



- **18-bit (110 dBFS) spur-free dynamic range**
- **Alias protection**
- **Tunable digital filtering**
- **8 Mbyte FIFO memory**
- **Up to 25 MByte/sec data transfer rate**
- **Internal or external clock**

The Agilent E1430A is more than a digitizer, it is a complete A/D module. Included with its low distortion, low noise, analog-to-digital converter is flexible input signal conditioning, alias protection, tunable digital filtering, a deep FIFO memory and a choice of high-speed interfaces.

A remarkable A/D

Whether you analyze spectrums or capture transients, digitize IFs or record waveforms, at audio frequencies or baseband, the quality of your measurement starts with the quality of your analog-to-digital conversion. The digitizer in the E1430A uses a combination of dithering and an extraordinary on-the-fly distortion correction technique to produce up to

18 bits (110 dBFS) of distortion-free, spur-free, dynamic range. Low distortion digitizing means higher quality data—data that will reveal even more about the signal when averaged, filtered, or FFT'd.

The E1430A also has low noise. Low noise means better resolution on single-shot events and less processing to resolve the signal on repetitive events. For the E1430A the noise density is as good as -136 dBFS/Hz. The sensitivity on the lowest input range is -160 dBm/Hz. The noise figure is 14 dB.

Alias protection

Use the E1430A for spectrum analysis. Its built-in 4 MHz anti-alias filter is ideal for the Nyquist (2X highest frequency of interest) sampling common to that analysis. Alias filtering also limits the noise bandwidth of the input giving lower noise time-domain data as well. And, if you need the fastest rise times possible you can switch the filter out.



Agilent Technologies

Digital filtering

Sometimes you must narrow in on a signal to exclude unwanted signals or noise. The E1430A features multiple digital filters, with decimation, and a digital LO.

Filter bandwidths range from 4 MHz to 0.24 Hz, in octave steps. After the data is filtered, it is decimated, halving the effective sample rate while maintaining alias-protected Nyquist sampling. This means you get the best of both worlds, digital filtering to exclude unwanted signals, and alias-protected Nyquist sampling, the most data-efficient form of digitizing.

Tune the digital LO to center any of the digital filters on your signal of interest to maximize rejection of unwanted signals. Tune the center frequency of the filters anywhere in the 4 MHz input range of the module with

10 mHz resolution. Both the I and Q data is output from the filters and is available for processing by the user.

Sample rate control

A built-in temperature compensated 10 MHz crystal oscillator provides precise sample timing. An optional 10.24 MHz clock (opt AYD) is available for applications requiring the sample rate to be an exact power of 2.

Use the digital filter/decimation capability to reduce the sample rate. This feature reduces the effective sample rate in factor-of-2 steps from 5.0 MHz to 0.47 Hz.

If finer control of the sampling rate is needed an external clock input is available to accept an external sampling clock. And, multiple E1430A's can be connected to sample synchronously.

Signal conditioning for flexibility

Signal conditioning for flexible AC/DC coupling and 11 attenuation/gain ranges protect the digitizer, letting you digitize a wide range of signal amplitudes.

Memory for signal capture

A high-speed, 8 Mbyte FIFO memory can be used to capture signals. Use the FIFO feature to store new data while old data is being read out, ensuring gap free data.

Local Bus for highest speed data transfer

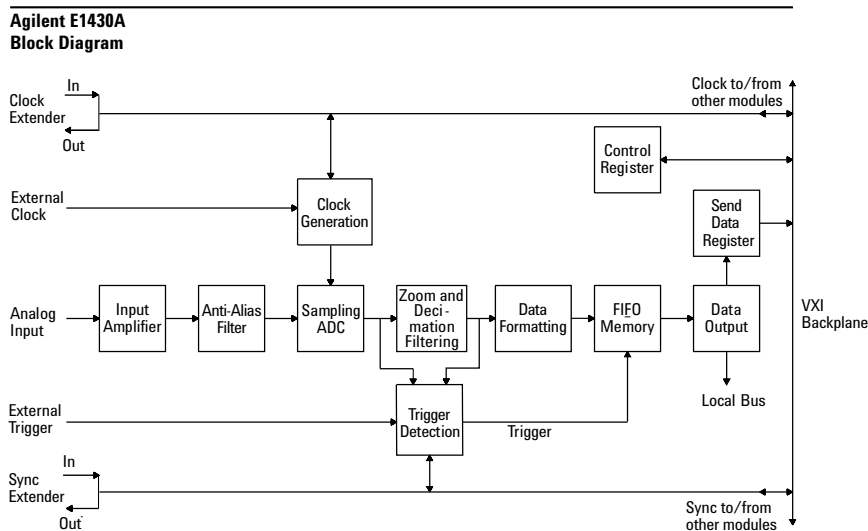
Transfer data off the module over VXI's VME bus or use the high-speed Local Bus. Over the Local Bus the E1430A can transfer blocks of data out at rates up to 40 MBytes/sec.

Programming

Program the E1430A from VEE and ITG using the preprogrammed drivers that come with VEE. Or, for the highest speed control and data transfers, program the E1430A's registers directly. A library of C functions is provided to simplify user program development. Filter correction functions are included as well. Source code is included to allow user modification, recompilation to a different target computer, and to provide examples of register programming.

Summary

When high-resolution, low-distortion, robust data is the key, when signal conditioning, filtering, on board memory and fast data transfers are a must, the E1430A is the answer to your digitizing needs.



Specifications

Specifications describe warranted performance over the temperature range of 0°C to 55°C (except where noted) and include a 30-minute warm-up from ambient conditions and automatic calibrations enabled unless otherwise noted. Supplemental characteristics, identified

as “typical” or “characteristic,” provide useful information by giving non-warranted performance parameters. Typical performance is applicable over ±5°C from the temperature during the most recent measurement calibration and is not warranted.

Analog Input

Input Modes		DC coupled, AC coupled, grounded; Single-ended, differential												
Input Ranges	Input voltage ranges (clipping voltages):	<table border="0"> <tr> <td>±8 Vpk (28 dBm)</td> <td>±0.125 Vpk (-8 dBm)</td> </tr> <tr> <td>±4 Vpk (22 dBm)</td> <td>±62.5 mVpk (-14 dBm)</td> </tr> <tr> <td>±2 Vpk (16 dBm)</td> <td>±31.25 mVpk (-20 dBm)</td> </tr> <tr> <td>±1 Vpk (10 dBm)</td> <td>±15.625 mVpk (-26 dBm)</td> </tr> <tr> <td>±0.5 Vpk (4 dBm)</td> <td>±7.8125 mVpk (-32 dBm)</td> </tr> <tr> <td>±0.25 Vpk (-2 dBm)</td> <td></td> </tr> </table>	±8 Vpk (28 dBm)	±0.125 Vpk (-8 dBm)	±4 Vpk (22 dBm)	±62.5 mVpk (-14 dBm)	±2 Vpk (16 dBm)	±31.25 mVpk (-20 dBm)	±1 Vpk (10 dBm)	±15.625 mVpk (-26 dBm)	±0.5 Vpk (4 dBm)	±7.8125 mVpk (-32 dBm)	±0.25 Vpk (-2 dBm)	
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	Maximum input voltage without damage:	8 VRMS for any time interval > 10 ms												
Input Impedance		50 Ω ±1% DC; > 40 dB return loss to 4 MHz; DC coupled or grounded modes only												
AC Coupling		In AC coupled mode, a 0.2 μF ±10% capacitor is placed in series with the input signal. Maximum DC voltage without damage is ±50 V when AC coupling is used.												
Common Mode Characteristics	Impedance to chassis ground:	47 Ω ±10% in parallel with 0.04 μF ±10%, differential input mode; < 0.1 Ω, single-ended input mode												
	Maximum common mode current	±1 Amp peak; diode clamped to < ±1 V peak without damage:												
	Common mode response:	< (-90 + 20 × LOG(Vcom)) dBfs, range ≥ 125 mV < (-80 + 20 × LOG(Vcom)) dBfs, range = 62.5 mV < (-65 + 20 × LOG(Vcom)) dBfs, range ≤ 31.25 mV												
	Note: The common mode source for these characteristics is a sine wave voltage source of Vcom mV applied through a 50 W series resistor. The characteristics apply for source frequencies < 4 MHz.													

Accuracy

Resolution	Raw ADC resolution:	23 bits, two's complement
	After digital zoom and filter operations:	32 bits, full resolution mode; 16 bits, reduced resolution mode
Amplitude Accuracy	Absolute voltage measurement accuracy:	±0.03 dB (< 100 kHz, ±1 V input range, 25°C, analog alias filter on, digital decimation filters off, DC coupled)
	Range accuracy (relative to ±1 V range):	±0.03 dB (for all ranges), < 100 kHz
	Alias filter off mode:	±0.02 dB relative to alias filter on mode, 12 kHz
	Temperature drift:	< 0.001 dB per °C of deviation from 25°C
DC Offset	Programmable DC offset:	
	Resolution:	< 0.05% of input range clipping voltage
	Range (minimum):	± 50% of input range clipping voltage, range ≥ 62.5 mV
	Input bias current:	< 64 μA (in parallel with 50 Ω input load)
	DC offset voltage vs temperature: (% of clipping voltage)	< ±0.01%/°C for 62.5 mV and higher ranges; < ±0.1%/°C for ranges < 62.5 mV

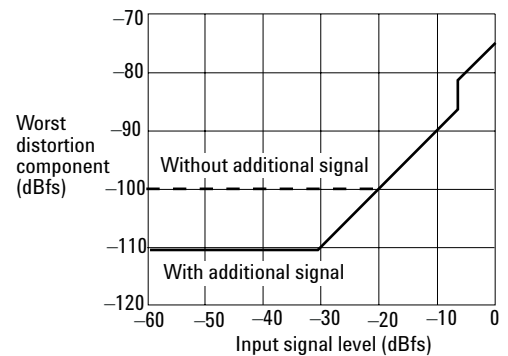
Dynamic Range

Note: If you reset the E1430A, and your application depends on the dynamic range specifications, allow at least 20 seconds after the reset for the ADC correction to settle before beginning your measurement.

Signal-to-Noise Ratio	The reference signal is a sine wave with peaks at the clipping voltage of the current range.	
	Alias filter on:	70 dB, range ≥ 62.5 mV; 62 dB, range ≤ 31.25 mV
	Alias filter off:	66 dB, range ≥ 62.5 mV; 53 dB, range ≤ 31.25 mV
Input Noise Density	(Alias filter on, ADC sample clock ≥ 10 MHz)	
	Range ≥ 62.5 mV:	-136 dBfs/Hz, $f > 100$ kHz
		-134 dBfs/Hz, 10 kHz $\leq f < 100$ kHz
		-130 dBfs/Hz, 2 kHz $\leq f < 10$ kHz
		$(-97 - 10 \times \text{LOG}(f))$ dBfs/Hz, $f < 2$ kHz
Range ≤ 31.25 mV:	-127 dBfs/Hz, $f \geq 200$ kHz	
	-122 dBfs/Hz, 20 kHz $< f < 200$ kHz	
	$(-79 - 10 \times \text{LOG}(f))$ dBfs/Hz, $f < 20$ kHz	
Spurious Signals (Between 0 to 4 MHz; terminated with 50 Ω at input connector)	< -110 dBfs, alias filter on, DSP clock = ADC clock < -95 dBfs, alias filter on, DSP clock \neq ADC clock < -70 dBfs, alias filter off, DSP clock = ADC clock	

Distortion	Harmonic distortion products to 4 MHz (Includes aliased distortion components)	
	for inputs < -6 dBfs	< -80 dBc or < -110 dBfs
	for inputs > -6 dBfs	< -75 dBc or < -110 dBfs
	Intermodulation distortion products to 4 MHz (Includes aliased distortion components)	
	for inputs < -9 dBfs	< -80 dBc or < -110 dBfs
	for inputs > -9 dBfs	< -75 dBc or < -110 dBfs

Distortion vs Input Signal



Phase Noise	$F_{in} < 4$ Mhz, vibration $< 0.01G$	
	Phase noise density: (single sideband power density)	< -128 dBc/Hz, $\Delta f = 100$ Hz
		< -122 dBc/Hz, $\Delta f = 50$ Hz
		< -92 dBc/Hz, $\Delta f = 5$ Hz
	Discrete sidebands: (5 Hz $< \Delta f < 1$ MHz)	< -110 dBc, internal clock
< -80 dBc, internal clock distributed on backplane		

Clock

Note: The sideband specification for the back-plane distributed clock requires that all modules in the mainframe comply with the VXI 1.4 specification for ECL trigger lines; and that the 10 MHz VXI system clock be turned off. External clock input must be disconnected when not being used for ADC clock.

Clock I/O Connections	External ADC clock input (ExtClk):	BNC input compatible with TTL, ECL, and > -6 dBm sine waves. AC coupled with input impedance of 1 k Ω above 10 kHz. ± 10 V absolute maximum input without damage
	Clock extender input:	ECL-10K compatible, 50 Ω termination to -2 V, SMB, -7 V to +0.5 V without damage
	Clock extender output:	ECL-10K compatible, SMB
	Sync extender input:	ECL-10K compatible, SMB, -7 V to +0.5 V without damage
	Sync extender output:	ECL-10K compatible, SMB
Clock sources	ADC clock:	Internal 10 MHz clock (optional 10.24 MHz) External clock, BNC input (the external clock frequency must be > 100 kHz if the DSP clock is the ADC clock, and must be < 4.9 MHz if the DSP clock is internal) ECL clock, SMB input
	DSP clock:	Internal 10 MHz clock (optional 10.24 MHz) ADC clock (ADC clock must be > 100 kHz in this mode)
Internal Clock	Frequency:	10 MHz (optional 10.24 MHz)
	Accuracy:	± 70 Hz, 0 $^{\circ}$ C to 40 $^{\circ}$ C
	Jitter (typical):	< 10 ps RMS, 1 s interval (see phase noise specification for spectral content of jitter)
Sampling skew (typical)	Within mainframe:	5 ns
	Between mainframes:	20 ns, clock extended via a 1-M coaxial cable

Trigger

Trigger Sources		External TTL
		Level
		LOG(Magnitude)
		Software (via register write)
Slope		Positive/negative
Threshold	Level Trigger:	$V_{range} \times N/128$, $-128 \leq N \leq 128$; hysteresis is $V_{range}/32$
	LOG(Magnitude) Trigger:	$V_{range}(\text{dBm}) - N \times 0.375$ dBm, $0 \leq N \leq 255$; hysteresis is 1.5 dB
External Trigger Input		TTL, BNC, ± 10 V absolute maximum input without damage

Trigger (continued)

Trigger Offset	Resolution (in output sample periods):	1 sample, 32-bit complex data 2 samples, 16-bit complex or 32-bit real data 4 samples, 16-bit real data
	Maximum pre-trigger delay:	1,048,575 x trigger offset resolution
	Maximum post-trigger delay:	8,388,607 x trigger offset resolution

Filtering

Total Frequency Response	<p>Total frequency response is: $H(f) = H_{analog}(f) \times H_{digital} \cdot N$</p> $\left(\frac{f - f_0}{f_s} \right)$ <p>where: f = input signal frequency f₀ = zoom center frequency (zero in baseband mode) f_s = ADC sampling frequency (10 MHz with standard internal clock) N = digital filter bandwidth selector N = 0, 1, 2, ..., 24</p>
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Analog Frequency Response (H_{analog})	Analog Flatness (peak to peak)	<p>Alias filter on: 03 dB, f ≤ 100 kHz; 0.25 dB, f ≤ 2.5 MHz; 0.8 dB, f ≤ 4 MHz</p> <p>Alias filter off: 0.25 dB, f ≤ 4 MHz; 3 dB nominal, f = 20 MHz</p> <p>Stopband rejection: 100 dB, f > 6 MHz, alias filter on</p>
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Analog Frequency Response Function (nominal), with alias filter off	$H_{analog}(f) = \frac{1}{(1 - s/c_0) \prod_{n=1}^2 [(1 - s/c_n)(1 - s/c_n^*)]} \Bigg _{s = j2\pi f}$ <table border="1"> <thead> <tr> <th>n</th> <th>c_n / 2π</th> </tr> </thead> <tbody> <tr> <td>0</td> <td>20 MHz</td> </tr> <tr> <td>1</td> <td>40 + j × 52 MHz</td> </tr> <tr> <td>2</td> <td>50 + j × 120 MHz</td> </tr> </tbody> </table>	n	c _n / 2π	0	20 MHz	1	40 + j × 52 MHz	2	50 + j × 120 MHz
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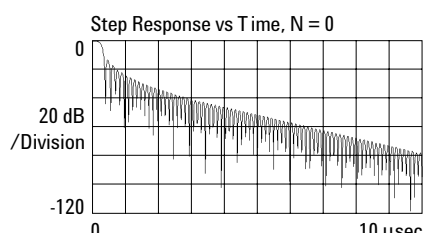
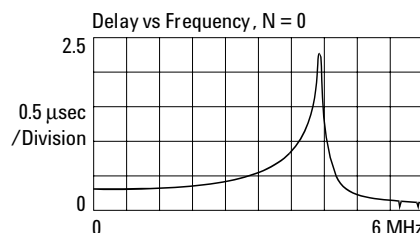
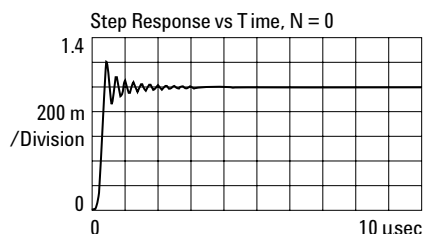
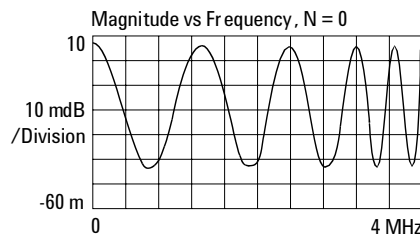
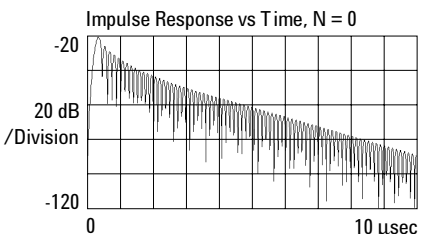
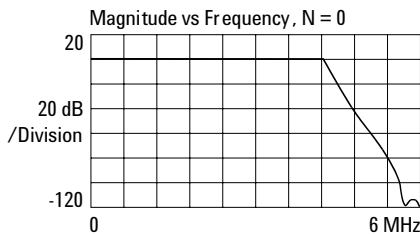
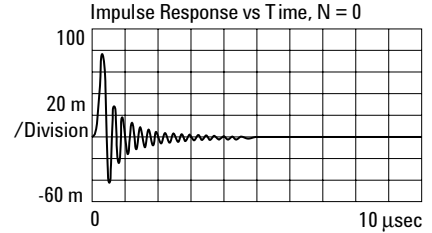
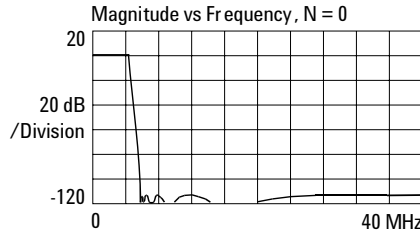
Analog Frequency Response Function (nominal), with alias filter on	$H_{analog}(f) = \frac{\prod_{n=1}^5 [(1 - s/a_n)(1 - s/a_n^*)]}{(1 - s/b_0) \prod_{n=1}^5 [(1 - s/b_n)(1 - s/b_n^*)]} \Bigg _{s = j2\pi f}$ <table border="1"> <thead> <tr> <th>n</th> <th>a_n (Radians/sec)</th> <th>b_n (Radians/sec)</th> </tr> </thead> <tbody> <tr> <td>0</td> <td></td> <td>-8.2909964 × 10⁶</td> </tr> <tr> <td>1</td> <td>j3.4904432 × 10⁷</td> <td>-7.5372809 × 10⁶ + j9.0528495 × 10⁶</td> </tr> <tr> <td>2</td> <td>j3.7024164 × 10⁷</td> <td>-5.7386094 × 10⁶ + j1.6425689 × 10⁷</td> </tr> <tr> <td>3</td> <td>j4.2617433 × 10⁷</td> <td>-3.7379055 × 10⁶ + j2.1470763 × 10⁷</td> </tr> <tr> <td>4</td> <td>j5.6601087 × 10⁷</td> <td>-2.0233064 × 10⁶ + j2.4424917 × 10⁷</td> </tr> <tr> <td>5</td> <td>j1.0424240 × 10⁸</td> <td>-6.3191539 × 10⁵ + j2.5754323 × 10⁷</td> </tr> </tbody> </table>	n	a _n (Radians/sec)	b _n (Radians/sec)	0		-8.2909964 × 10 ⁶	1	j3.4904432 × 10 ⁷	-7.5372809 × 10 ⁶ + j9.0528495 × 10 ⁶	2	j3.7024164 × 10 ⁷	-5.7386094 × 10 ⁶ + j1.6425689 × 10 ⁷	3	j4.2617433 × 10 ⁷	-3.7379055 × 10 ⁶ + j2.1470763 × 10 ⁷	4	j5.6601087 × 10 ⁷	-2.0233064 × 10 ⁶ + j2.4424917 × 10 ⁷	5	j1.0424240 × 10 ⁸	-6.3191539 × 10 ⁵ + j2.5754323 × 10 ⁷
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5	j1.0424240 × 10 ⁸	-6.3191539 × 10 ⁵ + j2.5754323 × 10 ⁷																				

Digital Filter Response (H_{digital})	<p>Amplitude flatness (1 ≤ N ≤ 24): + 0/-0.23 dB, f - f₀ < 0.36 × fs/2^N</p> <p>Stopband rejection (1 ≤ N ≤ 24): > 111 dB, f - f₀ < 0.64 × fs/2^N</p>
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Frequency Response Function:	$H_{digital}, N \left(\frac{f - f_0}{f_s} \right) = \begin{cases} 1, N = 0 \\ \prod_{n=1}^N \left(\frac{z^3 + 2z^2 + 2z + 1}{4z^3 + 2z} \right)^5 \Bigg _{z = e^{j2\pi(f - f_0)/f_s}}, N > 0 \end{cases}$
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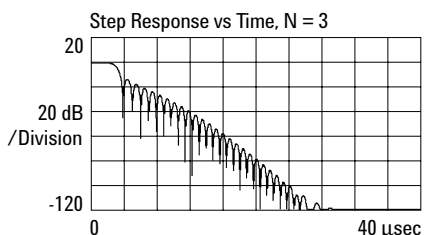
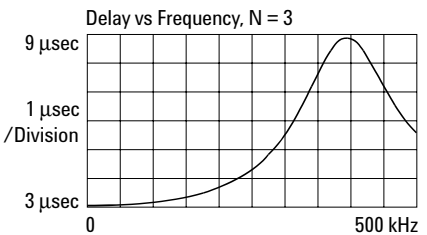
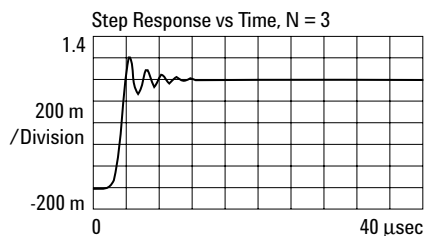
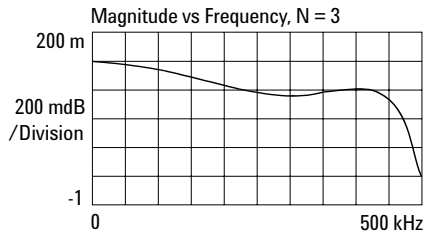
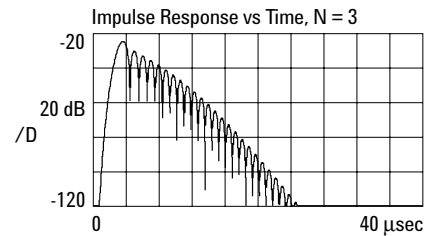
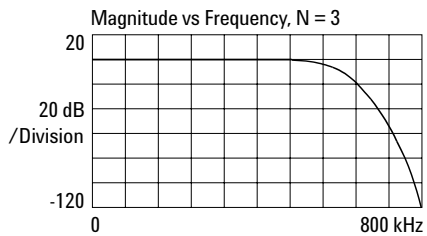
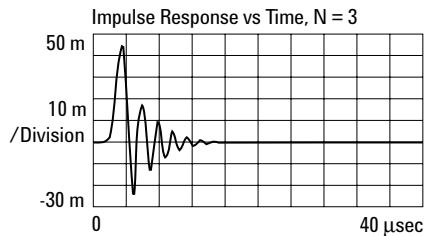
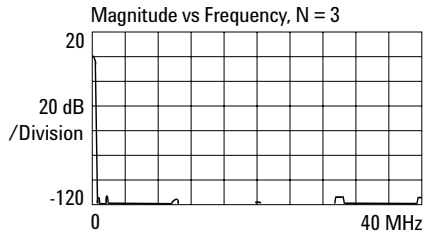
Filter characteristics for nominal 4 MHz analog anti-alias filter

The following graphs are derived from the analog frequency response function on page 5. They describe the behavior of the 4 MHz analog anti-alias filter located between the ADC and the input connector on the E1430A. All other filters are disabled. Three frequency versus magnitude response curves are provided: Broadband (0 to 40 MHz), Medium band (0 to 6 MHz) and Narrowband (0 to 4 MHz). Graphs for phase delay, step response and impulse response are also provided. The second graph of the impulse and step responses shows the deviation of the absolute value of the response from its final value in dB. That is, the step response will settle to within 0.1% (-60 db) of its final value in 6.4 μ sec.



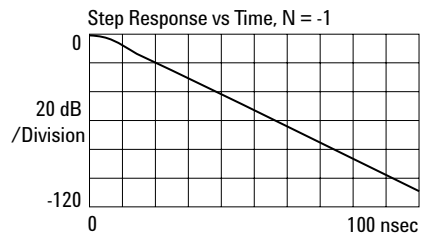
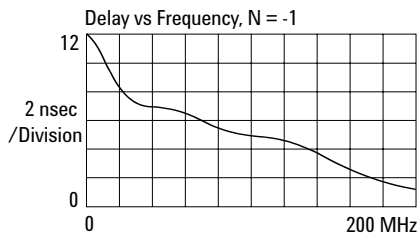
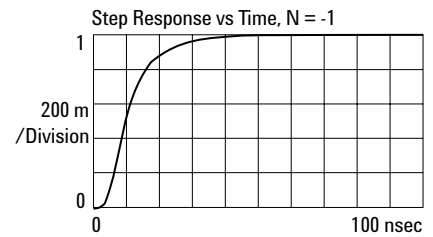
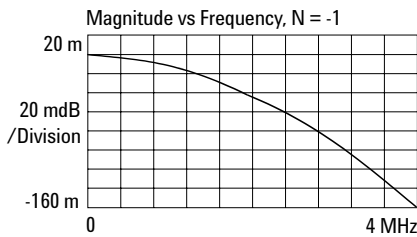
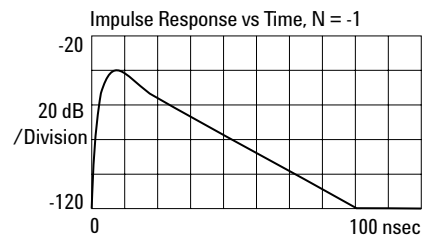
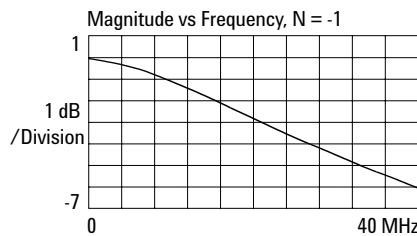
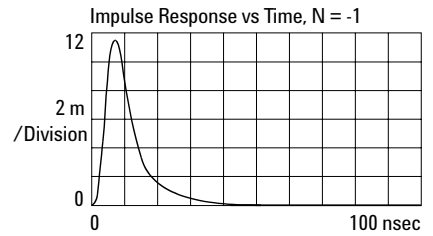
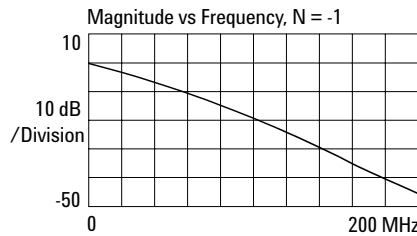
Filter characteristics for 500 kHz digital filter and analog anti-alias filter

The following graphs are derived from the frequency response functions on page 5. These graphs show the combined response of the 4 MHz analog anti-alias filter that precedes the ADC and the 500 kHz digital filter that follows the ADC. The responses are dominated by the 500 kHz filter. The shape of the responses is typical of the E1430A digital filters and can be used to estimate the behavior of the < 500 kHz digital filters. Three frequency versus magnitude response curves are provided: Broadband (0 to 40 MHz), Medium band (0 to 800 kHz) and Narrowband (0 to 500 kHz). Graphs for phase delay, step response and impulse response are also provided. The second graph of the impulse and step response shows the deviation of the absolute value of the response from its final value in dB. That is, the step response will settle within 0.1% (-60 dB) of its final value in 16 μ sec.



**Filter characteristics with all filtering off
(based on an approximate model)**

The following graphs are derived from an approximate model of the ADC frequency response when all filters, including the analog anti-alias filter, are switched off. Three frequency versus magnitude response curves are provided: Broadband (0 to 200 MHz), Medium band (0 to 40 MHz) and Narrowband (0 to 4 MHz). Graphs for phase delay, step response and impulse response are also provided. The second graph of the impulse and step responses shows the deviation of the absolute value of the response from its final value in dB. That is, the step response will settle to within 0.1% (-60 dB) of its final value in 58 nsec.



Programming	All functions are programmable via the VXI register interface.	
	Center Frequency	
	Resolution:	ADC clock frequency/(1024 x 109)
	Range:	±ADC clock frequency/2
	Filtering and Decimation	
	Bandwidths (-15 dB):	±0.5 x Fs/2 ^N , 1 ≤ N ≤ 24 (See the frequency response section for filter characteristics)
	Output sample rate:	Fs/2 ^N (Nyquist sampled), 2 x Fs/2 ^N (2X over-sampled)
	Data Output	
	Formats:	real, complex
	Resolution:	16 bits, 32 bits
	Output Ports:	VME data transfers; Local Bus data transfers
	Transfer rate:	40 Mbyte/s, local bus, block mode 20 MByte/s, local bus, continuous mode 3 MByte/s, VME
	Block sizes:	8, 16, 32, ..., 8388608 bytes
	Measurement modes:	Block mode (individually triggered blocks); continuous mode
	Information Available in Read Registers	
	Manufacturer's Code:	4095 Decimal (Agilent Technologies)
	Model Code:	0454 Decimal (E1430A)
	Other:	Logical address, status, measurement loop state, data
	Status bits:	Data word ready, data block available, armed, measurement done, overload, ADC error
	Interrupts:	Two independent priority interrupts initiated by masked status bits.
	Memory:	8 Mb (4 MSamples, 16 bit), FIFO
General	Standards Compliance:	VXI (Rev. 1.4); Register based; A16/D16
	DC voltage/current required:	+5 V/4.2 A, -5.2 V/4.2 A, -2 V/0.3 A, +12 V/0.3 A, -12 V/0.1 A
	Dynamic current required:	+5 V/0.5 A, -5.2 V/0.2 A, -2 V/0.1 A, +12 V/0.05 A, -12 V/0.02 A
	Size:	(Single slot, C-size VXI module)
	Dimensions:	14 inches deep, 9.2 inches high, 1.2 inches wide (approx. 36 cm deep, 23 cm high, 3 cm wide)
	Weight:	3.9 pounds (approx. 1.8 kg)
	Temperature Operating:	0°C to 55°C
	Temperature Storage:	-20°C to 65°C
	Humidity, non-condensing	
	Operating:	10% to 90% at 40°C
	Storage:	10% to 90% at 40°C
	Altitude Operating:	4600 m (15,000 ft) above 2285 m (7500 ft), derate operating temperature by -3.6°C per 1000 m (-1.1° C per 1000 ft)
	Altitude Storage:	4600 m (15,000 ft)
	Calibration interval:	1 year
	Warm-up time:	1 minute

Backplane Connector Shields

The backplane connector shields are required for RFI compliance with the EN55011 and CISPR11 standards. Order optional RFI backplane shields for your VXI maniframe—they are not required for MFRAME1.

Warranty

This product is distributed warranted, and supported by Agilent Technologies.

The E1430A comes with a 1-year warranty. During that period, the unit will either be replaced or repaired, at Agilent Technologies' option, and returned to the customer without charge.

Ordering Information

E1430A	10 MSample/sec ADC with filter and memory
E1430A-0B0	Delete manual set
E1430A-0B1	Add manual set
E1430A-AYD	10.24 MHz time base
E1439A/B-J01	1.2 GB FIFO memory
E1439A/B-144	144 MB FIFO memory
E1439A/B-288	288 MB FIFO memory

Related Agilent Literature

E1437A 20 MSample/Second ADC with Filter and FIFO Product Overview
literature number 5965-6893E

E1437A 20 MSample/Second ADC with Filter and FIFO Technical Specifications
literature number 5965-9774E

E1438A/B 100 MSample/Second Digitizer with DSP and Memory Product Overview
literature number 5968-7348E

E1438A/B 100 MSample/Second Digitizer with DSP and Memory Data Sheet
literature number 5968-8233E

E1439A/B VXI 70 MHz IF ADC with Filters and Memory Data Sheet
literature number 5980-1260E

E9830A Delay Memory Module Product Overview
literature number 5968-7349E

Agilent Test Systems and VXI Products Catalog
literature number 5980-0307E

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(fax) 800 820 2816

Europe:
(tel) (31 20) 547 2323
(fax) (31 20) 547 2390

Japan:
(tel) (81) 426 56 7832
(fax) (81) 426 56 7840

Korea:
(tel) (82 2) 2004 5004
(fax) (82 2) 2004 5115

Latin America:
(tel) 305 269 7500
(fax) 305 269 7599

Taiwan:
(tel) 0800 047 866
(fax) 0800 286 331

Other Asia Pacific Countries:
(tel) (65) 6375 8100
(fax) (65) 6836 0252
Email: tm_asia@agilent.com

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